# DELIVERY SPECIFICATION

 SPEC. No.
 C-150C-g

 D A T E :
 Feb., 2022

То

# **Non-Controlled Copy**

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME Multilayer Ceramic Chip Capacitors (Guaranteed at High Temperature) Bulk and tape packaging [RoHS compliant] C1005,C1608,C2012,C3216,C3225,C4532,C5750 Type NP0,X8R,X8L Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

# RECEIPT CONFIRMATION

DATE:	YEAR	MONTH	DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge	APPROVED	CHECKED	Person in charge

#### SCOPE

This delivery specification shall be applied to chip type multilayer ceramic capacitors to be delivered to

#### **PRODUCTION PLACES**

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

#### PRODUCT NAME

The name of the product to be defined in this specifications shall be  $\underline{C} \diamond \diamond \diamond \diamond O O \triangle \triangle \Box \Box \Box \times$ .

#### **REFERENCE STANDARD**

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

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#### <EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	February, 2022	C-150C-g

#### 1. CODE CONSTRUCTION

(Example)		<u>BR 1E</u> 2) (3)	<u>103</u> (4)	<u>K</u> (5)	<u>T</u> (6)	<u>    0000                             </u>		
(1) Case siz	. ,							
			D	_	Termina	al electrode		
		L G	B	V V	V			
	B					-		
	т							
				1				
	Internal electro	ode		_/				
		Ceramic di	electric					
Case size			Dimens	sions (Uni	t : mm)			
[EIA style]		V	V	Т		В	G	
C1005	1.00±0.0	5 0.50±	±0.05	0.50±0	.05	0.10 min.	0.30 min.	
[CC0402]	1.00±0.1	0 0.50 <u>+</u>	<u>⊧</u> 0.10	0.50±0	.10	0.10 mm.	0.30 mm.	
0.4000	1.60±0.1	0 0.80	±0.10	0.80±0	.10			
C1608 [CC0603]	1.60±0.1	±0.15 0.80±0.15		0.80±0	.15	0.20 min.	0.30 min.	
· · ·	1.60±0.2	0 0.80	±0.20	0.80±0	.20			
				0.60±0	.15		0.50 min.	
C2012	2.00±0.20	0 1.25	±0.20	0.85±0	.15	0.20 min.		
[CC0805]		_		1.25±0		0.20 mm.		
	2.00+0.2	5   1.25	+0.25 ∙ 0.15	1.25 <sup>+0</sup> - 0	.25 .15			
				0.60±0				
	2 20 . 0 2			0.85±0	.15			
C3216	3.20±0.20	0 1.60	<u>⊧</u> 0.20 <sup></sup>	1.15±0	.15	0.20 min.	1.00 min.	
[CC1206]				1.60±0	.20			
	3.20 <sup>+0.30</sup> - 0.1	0 1.60	+0.30 ∙0.10	1.60 <sup>+0</sup> - 0	.30 10			
	0.11	<u> </u>	0.10	1.25±0				
				1.60±0	.20			
C3225 [CC1210]	3.20±0.4	0 2.50±	±0.30	2.00±0	.20	0.20 min.		
[001210]				2.30±0	.20			
				2.50±0	.30			
				2.00±0	.20			
C4532 [CC1812]	4.50±0.4	4.50±0.40 3.20±0.40		2.30±0	.20	0.20 min.		
]				3.20±0	.30			
C5750	5.70±0.4	0 5.00-	<u>+</u> 0.40 —	2.30±0	.20	0.20 min.		
[CC2220]	5.7 0±0.4	0.001	-0.10	2.80±0	.30	0.20 mm.		

\* As for each item, please refer to detail page on TDK web.

#### (2) Temperature Characteristics

\* Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE

(3)	Rated	Voltage
-----	-------	---------

Symbol	Rated Voltage	Symbol	Rated Voltage
2 J	2 J DC 630 V		DC 25 V
2 W	DC 450 V	1 C	DC 16 V
2 E	DC 250 V	1 A	DC 10 V
2 A	DC 100 V	0 J	DC 6.3 V
1 H	DC 50 V	0 G	DC 4 V

#### (4) Rated Capacitance

(E)

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

-1
d acitance
000 pF

(5) Capacitance tolerance

Capacitance	Tolerance	Symbol
10pE and under	± 0.25 pF	С
10pF and under	± 0.5 pF	D
	± 5%	J
Over 10pF	± 10 %	К
	± 20 %	М
•		

#### (6) Packaging

\* C1005 type is applicable to tape packaging only.

Symbol	Packaging
В	Bulk
Т	Taping

#### (7) TDK internal code

### 2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitance	e tolerance	Rated capacitance
				1, 2, 3, 4, 5
1	NP0	10pF and under	D (± 0.5pF)	6, 7, 8, 9, 10
	Over 10pF		J (± 5%)	E – 6 series E – 12 series
2	X8R X8L	K (± 10 %)	M (± 20 %)	E – 6 series

#### Capacitance Step in E series

E series	Capacitance Step											
E- 6	1.0 1.5 2.2 3.3 4.7 6.8					.8						
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

#### 3. OPERATING TEMPERATURE RANGE

Min. operating	Max. operating	Reference		
Temperature	Temperature	Temperature		
-55°C	150°C	25°C		

### 4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

#### 5. P.C. BOARD

When mounting on an aluminum substrate, the capacitors are more likely to be affected by heat stress from the substrate.

Please inquire separate specification when mounted on the substrate.

#### 6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

#### 7. PERFORMANCE

table	e 1

No.	Item	Performance		Test o	r inspectio	n n	nethod	
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3x)			s (3×)		
2	Insulation Resistance	10,000M $\Omega$ or 500M $\Omega$ ·µF min. (As for the capacitors of rated voltage 16V DC and lower, 100M $\Omega$ ·µF min.)	Measuring voltage : Rated voltage (As for the capacitor of rated voltage 630V DC, apply 500V DC.) Voltage application time : 60s.				ed voltage	
3	Voltage Proof	Withstand test voltage without insulation breakdown or other	Class		ated age(RV)	,	Apply voltage	
		damage.		RV	≦100V	3	× rated voltage	
			1	100V<	RV≦500V	1.	$5 \times rated voltage$	
				500	N <rv< td=""><td>1.3</td><td colspan="2"><math>1.3 \times rated voltage</math></td></rv<>	1.3	$1.3 \times rated voltage$	
			2 RV≦10			2.5 × rated voltage		
			Voltage application time : 1s. Charge / discharge current : 50					
4	Capacitance	Within the specified tolerance.	《Class	1》				
			Capac	citance	Measurin frequenc		Measuring voltage	
			1000pF and under		1MHz±10	%	0.5 ~ 5 Vrms.	
			Over 1	000pF	pF 1kHz±10%			
			《Class 2》					
				citance	Measurin frequenc	-	Measuring voltage	
			10uF and under		1kHz±10 <sup>o</sup>	%	1.0±0.2Vrms	
			Over	10uF	120Hz±20	)%	0.5±0.2Vrms.	
5	Q (Class1)	Please refer to detail page on TDK web.	See No. conditio		s table for	me	asuring	
	Dissipation Factor (Class2)							

(contir	Í								
No.		Item	Performance				Test or inspection method		
6	Temperat Character of Capaci (Class1)	ristics	T.C. NP0 Capacita drift		perature Coefficient (ppm/°C) $0 \pm 30$ Within $\pm 0.2\%$ or $\pm 0.05$ pF, whichever larger.	са 85 М	alculated I 5°C tempe leasuring	re coefficient shall be based on values at 25°C and erature. temperature below 25°C 0°C and -25°C.	
7	Temperat Character of Capaci (Class2)	ristics	Capacitance Change (%) No voltage applied X8R : ±15 X8L : +15 - 40			st th ∆t	teps show termal equ tep. C <u>be calcu</u> Step 1 2 3 4 s for meas	e shall be measured by the n in the following table after uilibrium is obtained for each ulated ref. STEP3 reading Temperature(°C) $25 \pm 2$ $-55 \pm 2$ $25 \pm 2$ $150 \pm 2$ suring voltage, please contact les representative.	
8	Robustne Terminatio		-	cera	ation coming off, mic, or other	P. Aj ce di Pi (2	Reflow solder the capacitors on P.C.Board shown in Appendix2. Apply a pushing force gradually center of a specimen in a horizo direction of P.C.board. Pushing force : 5N (2N is applied for C1005 type.) Holding time : 10±1s		
9	Bending	External appearance	No mechan	ical d	amage.	P.		50 F R230	

No.	lte		Perfo	ormance	Test o	r inspection method	
10	Solderability	New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material.			Solder : Flux : Solder temp. : Dwell time : Solder position :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. 245±5°C 3±0.3s. Until both terminations are completely soaked.	
		T	A section				0.000.050
11	Resistance to solder heat	External appearance	No cracks are allowed and terminations shall be covered at least 60% with new solder.			Solder : Flux :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.
		Capacitance	ce Characteristics		Change from the value before test	Solder temp. :	260±5°C
			Class1 Class2	NP0 X8R X8L	Capacitance drift within $\pm 2.5\%$ or $\pm 0.25pF$ , whichever larger. $\pm 7.5\%$	Dwell time : Solder position : Pre-heating :	10±1s. Until both terminations are completely soaked. Temp. — 110~140°C
		Q (Class1)	Meet the initial spec. Meet the initial spec.			_	Time — $30\sim$ 60s.
		D.F. (Class2)				Leave the capacitors in ambient condition for Class 1 : 6~24h Class 2 : 24±2h before measurement.	
		Insulation Resistance	Meet the	initial s	pec.		
		Voltage proof	No insulation breakdown or other damage.				

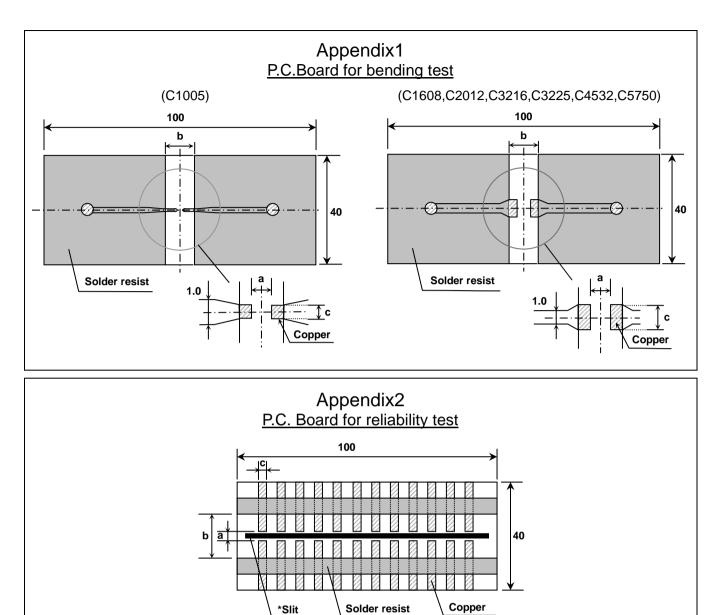
No.	lte	em	Performance	Test or inspection method
12	Vibration	External appearance Capacitance	No mechanical damage.         Characteristics       Change from the value before test         Class1       NP0       ±2.5% or ±0.25pF, whichever larger.         Class2       X8R val       ±7.5 %	Frequency : 10~55~10Hz Reciprocating sweep time : 1 min. Amplitude : 1.5mm Repeat this for 2h each in 3 perpendicular directions(Total 6h). Reflow solder the capacitors on a
		Q (Class1) D.F. (Class2)	Meet the initial spec.	P.C.Board shown in Appendix2 before testing.
13	Temperature cycle	External appearance Capacitance	No mechanical damage.           Characteristics         Change from the value before test	Expose the capacitors in the condition step1 through step 4 listed in the following table.Temp. cycle : 5 cyclesStepTemperature(°C)Time (min.)
			Class1NP0Please contactClass2X8R X8Lwith our sales representative.	1         -55 ± 3         30 ± 3           2         Ambient Temp.         2 ~ 5
		Q (Class1)	Meet the initial spec.	3         150 ± 2         30 ± 2           4         Ambient Temp.         2 ~ 5
		D.F. (Class2)	Meet the initial spec.	Leave the capacitors in ambient condition for Class 1 : 6~24h
		Insulation Resistance	Meet the initial spec.	Class 2 : 24±2h before measurement. Reflow solder the capacitors on a
		Voltage proof	No insulation breakdown or other damage.	P.C.Board shown in Appendix2 before testing.

No.	Item		Perfo	rmance	Test or inspection method			
14	Moisture Resistance	External appearance	No mechanical da	amage.	Test temp. : 40±2°C Test humidity : 90~95%RH			
	(Steady State)	Capacitance	Characteristics	Change from the value before test	Test time : 500 +24,0h			
			Class1 NP0	Please contact with our sales	Leave the capacitors in ambient condition for Class 1 : 6~24h			
			Class2 X8R X8L	representative.	Class 2 : 24±2h before measurement.			
		Q (Class1)	Capacitance	Q	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before			
			30pF and over 10pF and over	350 min. 275+5/2×C min.	testing.			
			under 30pF Under 10pF	200+10×C min.				
			C : Rated capa	citance (pF)				
		D.F. (Class2)	200% of initial spe	ec. max.				
		Insulation Resistance		•				
15	Moisture Resistance	External appearance	No mechanical da	amage.	Test temp. : 40±2°C Test humidity : 90~95%RH Applied voltage : Rated voltage			
		Capacitance	Characteristics	Change from the value before test	Test time : 500 +24,0h Charge/discharge current : 50mA or lower			
			Class1 NP0	Please contact with our sales	Leave the capacitors in ambient condition for			
			Class2 X8R X8L	representative.	Class 1 : 6~24h Class 2 : 24±2h before measurement.			
		Q (Class1)	Capacitance	Q	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before			
			30pF and over Under 30pF	200 min. 100+10/3×C min.	testing.			
			C : Rated capa		Initial value setting (only for class 2)			
		D.F. (Class2)	200% of initial spe	· · · /	Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient			
		Insulation Resistance	smaller.	⊷µF min. whichever tors of rated voltage er, 5MΩ·µF min.)				

No.			Performance			Test or inspection method		
16	Life	External appearance	No mecha	nical da	amage.	Test temp. : 150±2°C Applied voltage : Please contact with ou sales representative.		
		Capacitance	Characte	eristics	Change from the value before test	Test time : 1,000 +48,0h Charge/discharge current : 50mA or lower		
			Class1	NP0	Please contact	Leave the capacitors in ambient		
			Class2 X8R X8L		with our sales representative.	condition for Class 1 : 6~24h Class 2 : 24±2h before measurement.		
		Q				Reflow solder the capacitors on a		
		(Class1)	Capacitance		Q	P.C.Board shown in Appendix2 before		
			30pF and over 10pF and over under 30pF		350 min.	testing.		
					275+5/2×C min.	Initial value setting (only for class 2)		
			Under	10pF	200+10×C min.	Voltage conditioning 《After voltage		
			C : Rated capacitance (pF)			treat the capacitors under testing temperature and voltage for 1 hour,		
		D.F.	200% of in	itial spe	ec. max.	leave the capacitors in ambient		
		(Class2)				condition for 24±2h before measurement.		
		Insulation Resistance		or 50M r smalle	lΩ·µF min. er.	Use this measurement for initial value		
			(As for the	capaci	itors of rated voltage			
			16V DC a	nd lowe	er, 10MΩ·µF min.)			

\*As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14, leave capacitors at

150 0,-10°C for 1 hour and measure the value after leaving capacitors for  $24 \pm 2h$  in ambient condition.



\* It is recommended to provide a slit on P.C.Board for C3225,C4532 and C5750.

			(Unit : mm)
Symbol Case size	а	b	с
C1005 [CC0402]	0.4	1.5	0.5
C1608 [CC0603]	1.0	3.0	1.2
C2012 [CC0805]	1.2	4.0	1.65
C3216 [CC1206]	2.2	5.0	2.0
C3225 [CC1210]	2.2	5.0	2.9
C4532 [CC1812]	3.5	7.0	3.7
C5750 [CC2220]	4.5	8.0	5.6

1. Material : Glass Epoxy(As per JIS C6484 GE4)

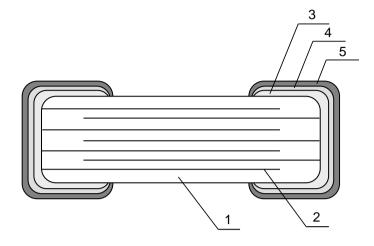
2. Thickness : Appendix 1 — 0.8mm — 1.6mm

(C1005) (C1608,C2012,C3216,C3225,C4532,C5750)

: Appendix 2 — 1.6mm

Copper(Thickness:0.035mm) Solder resist

## 8. INSIDE STRUCTURE AND MATERIAL



No	NAME	MATERIAL				
No.	INAME	Class1	Class2			
1	Dielectric	CaZrO <sub>3</sub> BaTiO <sub>3</sub>				
2	Electrode	Nickel (Ni)				
3		Coppe	r (Cu)			
4	Termination	Nicke	l (Ni)			
5		Tin (Sn)				

### 9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 9.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.
- 9.2 Tape packaging is as per 13. TAPE PACKAGING SPECIFICATION.

\*C1005[CC0402] type is applicable to tape packaging only.

- 1) Inspection No.\*
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

\*Composition of Inspection No.

Example 
$$\underline{F} \ \underline{2} \ \underline{A} \ - \ \underline{23} \ - \ \underline{001}$$
  
(a) (b) (c) (d) (e)

(a) Line code

- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

\*Composition of new Inspection No. (Implemented on and after May 1, 2019 in sequence)

Example

Ι	F	2	Е	2	3	А	0	0	1
(a)	(b)	(C)	(d)	(6	(e)		f)	(0	g)

- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix(00 ~ ZZ)

\* It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases. Until the shift is completed, either current or new composition of inspection No. will be applied.

### **10. RECOMMENDATION**

As for C3225[CC1210] and larger, It is recommended to provide a slit (about 1mm width) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

### **11. SOLDERING CONDITION**

As for C1005[CC0402], C3225[CC1210] and larger, reflow soldering only. For other case sizes than the above, reflow soldering is recommended.

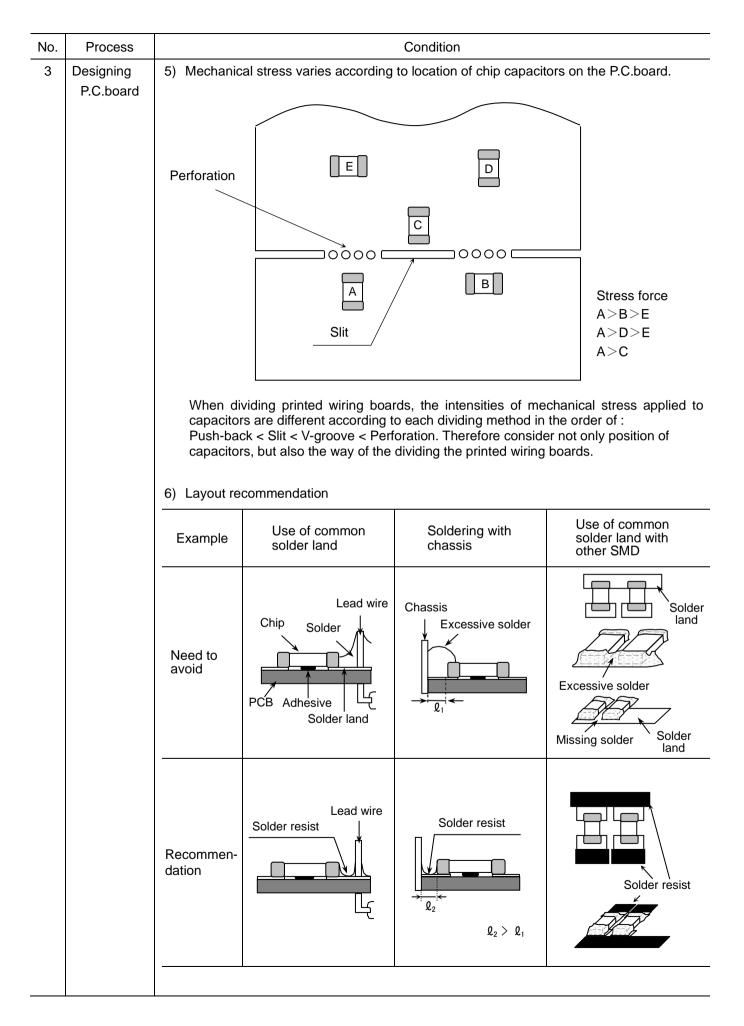
### **12. CAUTION**

No.	Process	Condition
1	Operating Condition (Storage, Use, Transportation)	<ul> <li>1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.</li> <li>1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of</li> </ul>
		taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		<ul> <li>2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use.</li> <li>During storage, keep the minimum packaging unit in its original packaging without opening it.</li> <li>Do not deviate from the above temperature and humidity conditions even for a short term.</li> </ul>
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		<ul> <li>1-2. Handling in transportation</li> <li>In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)</li> </ul>
2	Circuit design	2-1. Operating temperature
	Caution	<ol> <li>Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.</li> </ol>
		2) Surface temperature including self heating should be below maximum operating temperature.
		Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C. When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural
		<ul> <li>convection such as a cooling fan.)</li> <li>3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.</li> </ul>

No.	Process	Condition				
2	Circuit design	<ul> <li>2-2. When overvoltage is applied</li> <li>Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature.</li> </ul>				
		<ul> <li>2-3. Operating voltage</li> <li>1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V0-P must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, VP-P must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.</li> </ul>				
		Voltage         (1) DC voltage         (2) DC+AC voltage         (3) AC voltage				
		Positional Measurement (Rated voltage) $V_{0-P}$ $0$ $V_{0-P}$ $0$ $V_{P-P}$ $V_{$				
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)				
		Positional Measurement (Rated voltage)				
		<ul> <li>2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.</li> </ul>				
		<ol> <li>The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.</li> </ol>				
		<ol> <li>Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage.</li> </ol>				
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.				
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.				

No.	Process			Condition			
3	Designing P.C.board	capacitors. 1) The greater the am and the more likely	<ol> <li>The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations.</li> </ol>				
		3) Size and recommer	nded land dime	nsions.			
			Chip c	apacitors Solo	ler land		
					So	lder resist	
		Reflow soldering				(Unit : mm)	
		Case size	C1005	C1608	C2012	C3216	
		Symbol	[CC0402]	[CC0603]	[CC0805]	[CC1206]	
		Α	0.3 ~ 0.5	0.6 ~ 0.8	0.9 ~ 1.2	2.0 ~ 2.4	
		В	0.35 ~ 0.45	0.6 ~ 0.8	0.7 ~ 0.9	1.0 ~ 1.2	
		C	0.4 ~ 0.6	0.6 ~ 0.8	0.9 ~ 1.2	1.1 ~ 1.6	
		Case size Symbol	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]	-	
		A	2.0 ~ 2.4	3.1 ~ 3.7	4.1 ~ 4.8	-	
		В	1.0 ~ 1.2	1.2 ~ 1.4	1.2 ~ 1.4	-	
		С	1.9 ~ 2.5	2.4 ~ 3.2	4.0 ~ 5.0	-	
		_Flow soldering (Un	recommend)		(Unit : m	חm)	
		Case size Symbol	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC120		
		Α	0.7 ~ 1.0	1.0 ~ 1.3	2.1 ~ 2	.5	
		В	0.8 ~ 1.0	1.0 ~ 1.2	1.1 ~ 1	.3	
		С	0.6 ~ 0.8	0.8 ~ 1.1	1.0 ~ 1	.3	

lo.	Process	Condition					
3	Designing P.C.board	4) Recommend	ed chip capacitors layout is as follo	owing.			
			Disadvantage against bending stress	Advantage against bending stress			
		Mounting face	Perforation or slit	Perforation or slit			
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.			
			Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit			
		Chip arrangemen (Direction)	t	Perforation or slit			
			Closer to slit is higher stress	Away from slit is less stress			
		Distance fror slit					
			$( \mathfrak{Q}_1 < \mathfrak{Q}_2 )$	$( \mathfrak{Q}_1 < \mathfrak{Q}_2 )$			



No.	Process		Conditio	n		
4	Mounting	<ul><li>4-1. Stress from mounting head</li><li>If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions.</li></ul>				
		<ol> <li>Adjust the bottom surface and not p</li> </ol>	nting head to reach on the P.C.board			
		2) Adjust the mount	ing head pressure to be f	to 3N of static weight.		
		-	bottom side of the P.C.bo	ting head, it is important to provide ard.		
			Not recommended	Recommended		
		Single-sided mounting	Cra	ck Support pin underneath the capacitor.		
		Double-sides mounting	Solder peeling Crack	Support pin		
		capacitors to cause	e crack. Please control th	give mechanical impact on the e close up dimension of the centering nance and replacement of it.		
		4-2. Amount of adhes		← <u> </u>		
		_				
			xample : C2012 [CC080	5] C3216 [CC1206]		
				mm min.		
		-		~ 100µm		
		-	c Do not touc	h the solder land		

No.	Process		Condition			
5	Soldering	5-1. Flux selection Flux can seriously affect the persent select the appropriate flux.	erformance of capa	citors. Confirm the following to		
		<ol> <li>It is recommended to use a mil Strong flux is not recommended</li> </ol>		lux (less than 0.1wt% chlorine)		
		2) Excessive flux must be avoided	d. Please provide pro	oper amount of flux.		
		3) When water-soluble flux is used	d, enough washing i	s necessary.		
		5-2. Recommended soldering profi Refer to the following temperatur		oldering.		
		Reflow soldering				
		<del>≺</del>	heating Soldering Natu	ral cooling		
		Peak Temp Ο Ο Ο Ο Ο Ο Ο Ο Ο Ο Ο Ο Ο	Peak Temp time ed for C1608,C2012, se sizes. < temp and peak ten	C3216 types, but only reflow		
		Temp./Duration	Reflow s			
			Peak temp(°C)	Duration(sec.)		
		Solder Lead Free Solder	260 max.	10 max.		
		Sn-Pb Solder	230 max.	20 max.		
				20 1107.		
		Recommended solder compos Lead Free Solder : Sn-3.0Ag-				

No.	Process	Condition					
5	Soldering	5-4. Soldering profile : Flow method (Unrecommend) Refer to the following temperature profile at Flow soldering.					
		Reflow soldering	Over 60 sec. Peak Temp time is recommended for C16				
		Pb free solder is recommended, but if Sn-37Pb must be used, refer to below.           Temp./Duration         Flow soldering					
		Solder	Peak temp(°C)	Duration(s	sec.)		
		Lead Free Solo	der 260 max.	5 max			
		Sn-Pb Solder	250 max.	3 max			
		Recommended solder c Lead Free Solder : Sn- 5-6. Avoiding thermal shock 1) Preheating condition	-3.0Ag-0.5Cu				
		Soldering	Case size		Temp. (°C)		
		Reflow soldering	C1005(CC0402),C1608(C C2012(CC0805),C3216(C C3225(CC1210), C4532(C	C1206)	$\Delta T \leq 150$		
		Flow soldering	C5750(CC2220) C1608(CC0603),C2012(C C3216(CC1206)	-	$\Delta T \leq 130$ $\Delta T \leq 150$		

No.	Process		Condition	
5	Soldering	5-7. Amount of solder Excessive solder will induce temperature changes and it may detach the capacitors f	t may result in chip c	
		Excessive solder		Higher tensile force in chip capacitors to cause crack
		Adequate		<u>ximum amount</u> nimum amount
		Insufficient solder		Low robustness may cause contact failure or chip capacitors come off the P.C.board.
		<ul> <li>5-8. Sn-Zn solder</li> <li>Sn-Zn solder affects product relianelise contact TDK in advance</li> <li>5-9. Countermeasure for tombstom The misalignment between the repatterns should be minimized.</li> <li>the capacitors are mounted (in low reflow soldering.</li> <li>(Refer to JEITA RCR-2335C And the tombstone phenomenon.)</li> </ul>	when utilize Sn-Zn s ne mounted positions of The tombstone phe ongitudinal direction	f the capacitors and the land nomenon may occur especially ) in the same direction of the

No.	Process		Condition
6	Solder repairing	(also called a "blower") ra	
		capacitor compared to u capacitor uniformly with stress caused by quick Moreover, where ultra-s circuit board, reworking	heater may suppress the occurrence of cracks in the using a soldering iron. A spot heater can heat up a a small heat gradient which leads to lower thermal heating and cooling or localized heating. mall capacitors are mounted close together on a printed with a spot heater can eliminate the risk of direct contact dering iron and a capacitor.
		capacitor may occur due such an occurrence. Keep more than 5mm b The blower temperature The airflow shall be set	
		is standard and common Duration of blowing hot C2012(CC0805) and C3 C4532(CC1812) and C5 and melting temperature The angle between the 45degrees in order to w	air is recommended to be 10s or less for C1608(CC0603), 3216(CC1206), and 30s or less for C3225(CC1210), 5750(CC2220), considering surface area of the capacitor e of solder. nozzle and the capacitor is recommended to be ork easily and to avoid partial area heating. ng a soldering iron, preheating reduces thermal stress on
		Recommended rework	condition (Consult the component manufactures for details.)
		Distance from nozzle	5mm and over
		Nozzle angle	45degrees
		Nozzle temp.	400°C and less
		Airflow	Set as weak as possible (The airflow shall be the minimum value necessary for solder to melt in the conditions mentioned above.)
		Nozzle diameter	ø2mm (one-outlet type)
		Blowing duration	10s and less (C1608[CC0603], C2012[CC0805], C3216[CC1206]) 30s and less (C3225[CC1210], C4532[CC1812], C5750[CC2220])
		• Example of recomme	nded spot heater use
			One-outlet type nozzle
		Excess solder causes m in cracks. Insufficient so substrate and may resul of the printed wiring boa	d be suitable to from a proper fillet shape. The chanical and thermal stress on a capacitor and results older causes weak adherence of the capacitor to the t in detachment of a capacitor and deteriorate reliability ard. The propriate solder fillet shape for 5-7. Amount of solder.

No.	Process			Condition						
6	Solder repairing	6-2. Solder repair by solder iron								
		<ol> <li>Selection of the soldering iron tip         Tip temperature of solder iron varies by its type, P.C.board material a         solder land size. The higher the tip temperature, the quicker the ope         However, heat shock may cause a crack in the chip capacitors.         Please make sure the tip temp. before soldering and keep the peak         time in accordance with following recommended condition.     </li> </ol>								
				nual soldering Solder iron)						
		Te	eak mp Ω Ω ΔT	Preheating	As short as possible)					
		Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)								
		Case size	Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)				
		C1005(CC0402) C1608(CC0603) C2012(CC0805) C3216(CC1206)	350 max.	3 max.	20 max.	ø3.0 max.				
		C3225(CC1210) C4532(CC1812) C5750(CC2220)	280 max.							
		* Please preheat the or shock.	chip capacitors	s with the conditio	n in 6-3 to avoi	d the thermal				
				iron with ceramic the ceramic diele						
		3) It is not recomme	acitors.							
		6-3. Avoiding thermal	shock							
		Preheating condition	on							
		Soldering		Case size		Temp. (°C)				
				CC0402),C1608(CC CC0805),C3216(CC		∆T ≦ 150				
		Manual solde	C1812),							

No.	Process	Condition
7	Cleaning	<ol> <li>If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.</li> </ol>
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		<ul><li>2)-1. Insufficient washing</li><li>(1) Terminal electrodes may corrode by Halogen in the flux.</li></ul>
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		<ul><li>(3) Water soluble flux has higher tendency to have above mentioned problems</li><li>(1) and (2).</li></ul>
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/ℓ max. Frequency : 40 kHz max. Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
8	Coating and molding of the P.C.board	<ol> <li>When the P.C.board is coated, please verify the quality influence on the product.</li> <li>Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li> </ol>
		3) Please verify the curing temperature.

No.	Process		Condition	
9	Handling after chip mounted	<ul> <li>andling otherwise the Be</li> <li>Be</li> <li>Printed circuit board of proper tooling. Printed cropping jig as shown prevent inducing med (1)Example of a boar Recommended exclose to the cropping the capacitor is co Unrecommended of the pushing direction</li> </ul>	not to bend or distort the P.C. e chip capacitors may crack. and 	Twist Twist d out by hand, but by using t ld be carried out using a boar a board cropping apparatus e pushed from the back sid t bent and the stress applied is far from the cropping jig a he board, large tensile stress
		Outline of jig	Recommended Direction of load Components Load point	Unrecommended Load point Printed circuit board V-groove

No.	Process							
9	Handling after chip mounted <u>/</u> Caution	An o top a V-gro Unree	ple of a board cr utline of a printed and bottom blades boves on printed commended exa m, right and left citor.	l circuit board o s are aligned w circuit board w mple: Misalign	cropping machi vith one anothe hen cropping th ment of blade p	r along the lines ne board. position betweer	with the	
			Outline of mac	hine	Princip	le of operation		
		Top blade Printed circuit board V-groove Bottom blade						
					Cros	ss-section diagrar	n blade	
					V-groo	ove Bott	om blade	
			Decommonded	Unrecommended				
			Recommended Top blade	Top-bottom misalignment	Left-right misalignment	Front-rear misalignment		
			Board Board Bottom blade	Top blade	Top blade	Top blade		
		to be adju and bend	nctional check of usted higher for for the P.C.board, it ons off. Please ac	ear of loose co may crack the	ntact. But if the chip capacitor	pressure is exc s or peel the	essive	
		Item	Item Not recommended			Recommended		
		Board bending		Termination peeling Check pin		Support pir		

No.	Process	Condition
10	Handling of loose chip capacitors	<ol> <li>If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care.</li> </ol>
		2) Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack.
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
13	Caution during operation of equipment	<ol> <li>A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock.</li> <li>Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand.</li> <li>Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.</li> </ol>
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit.
		<ul> <li>3) Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments.</li> <li>(1) Environment where a capacitor is spattered with water or oil</li> <li>(2) Environment where a capacitor is exposed to direct sunlight</li> <li>(3) Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation</li> <li>(4) Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.)</li> <li>(5) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits.</li> <li>(6) Atmosphere change with causes condensation</li> </ul>
14	Others	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the
		<ul> <li>applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.</li> <li>(1) Aerospace/Aviation equipment</li> </ul>
		<ul> <li>(1) Norospassion matter equipment</li> <li>(2) Transportation equipment (cars, electric trains, ships, etc.)</li> <li>(3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2)</li> <li>(4) Power-generation control equipment</li> <li>(5) Atomic energy-related equipment</li> <li>(6) Seabed equipment</li> <li>(7) Transportation control equipment</li> <li>(8) Public information-processing equipment</li> <li>(9) Military equipment</li> <li>(10) Electric heating apparatus, burning equipment</li> <li>(11) Disaster prevention/crime prevention equipment</li> </ul>
		<ul> <li>(11) Disaster prevention/crime prevention equipment</li> <li>(12) Safety equipment</li> <li>(13) Other applications that are not considered general-purpose applications</li> </ul>
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

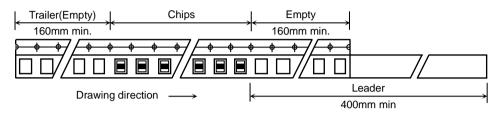
### **13. TAPE PACKAGING SPECIFICATION**

#### **1. CONSTRUCTION AND DIMENSION OF TAPING**

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4. Dimensions of plastic tape shall be according to Appendix 5, 6.

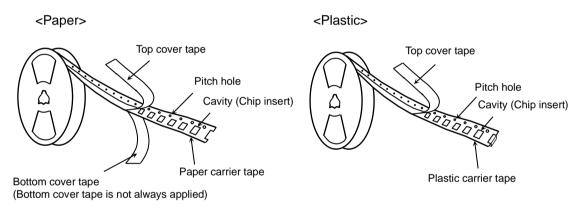
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of  $\emptyset$ 178 reel shall be according to Appendix 7, 8. Dimensions of  $\emptyset$ 330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping

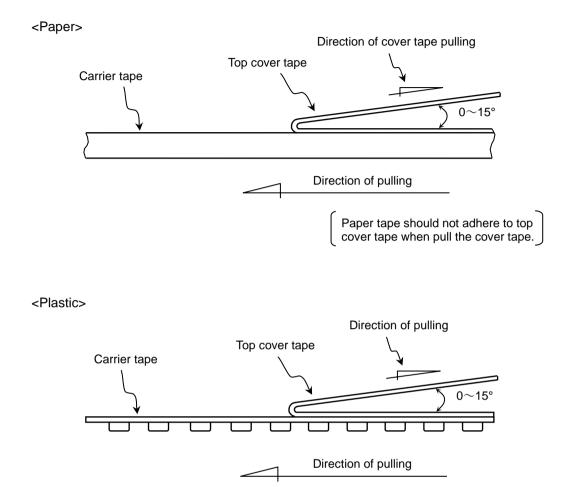


#### 2. CHIP QUANTITY

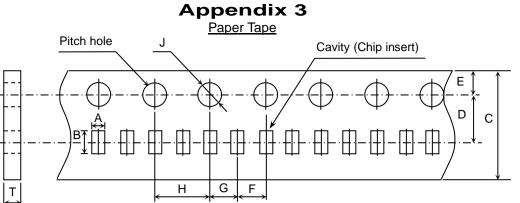
Please refer to detail page on TDK web.

#### 3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape) 0.05N < Peeling strength < 0.7N



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

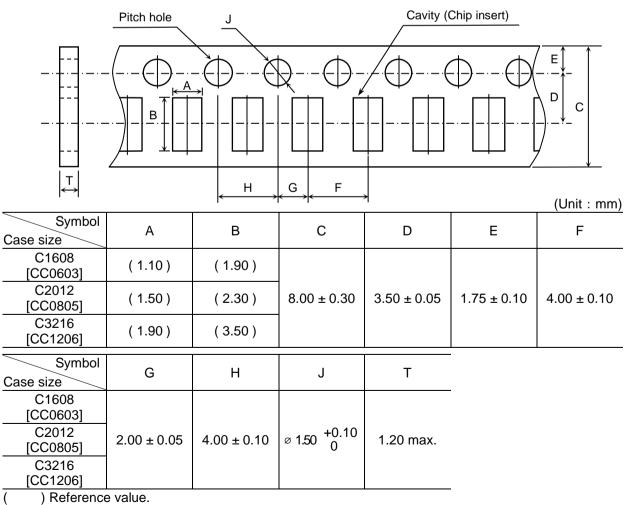


(Unit : mm)

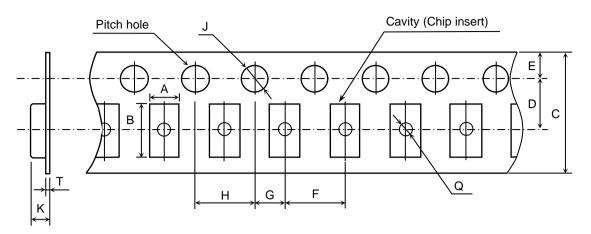
Symbol Case size	А	В	С	D	E	F
C1005 [CC0402]	( 0.65 )	(1.15)	8.00 ± 0.30	$3.50 \pm 0.05$	1.75 ± 0.10	$2.00 \pm 0.05$
Symbol Case size	G	н	J	т	-	
C1005 [CC0402]	2.00 ± 0.05	4.00 ± 0.10	ø 1.50 +0.10 0	0.60±0.05		
() Reference			•	•	•	

( ) Reference value.

# Appendix 4



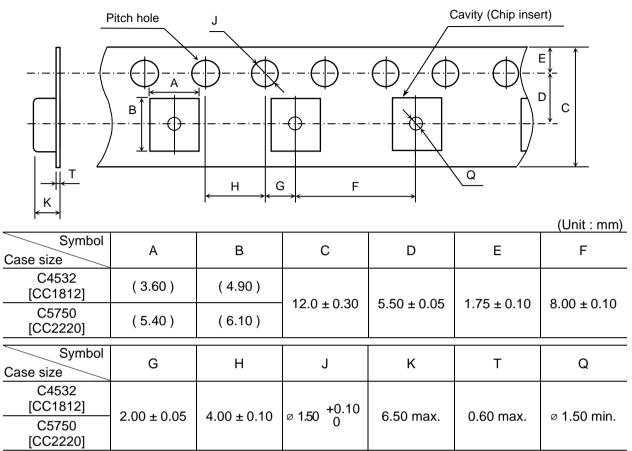
Plastic Tape



						(Unit : mm)
Symbol Case size	А	В	С	D	Е	F
C2012 [CC0805]	(1.50)	(2.30)	8.00 . 0.20	2 50 . 0.05		
C3216 [CC1206]	(1.90)	(3.50)	8.00 ± 0.30 *12.0 ± 0.30	3.50 ± 0.05 *5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 [CC1210]	(2.90)	(3.60)	12.0 ± 0.30	5.50 ± 0.05		
Symbol Case size	G	Н	J	К	Т	Q
C2012 [CC0805]				2 E0 mov		
C3216 [CC1206]	$2.00 \pm 0.05$	4.00 ± 0.10	ø 1.50 +0.10 0	2.50 max.	0.60 max.	ø 0.50 min.
C3225 [CC1210]				3.40 max.		

( ) Reference value.
 \* Applied to thickness, 2.5mm products.
 Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

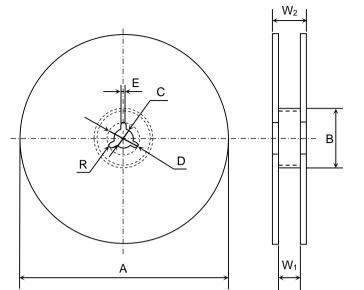
Plastic Tape



() Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

Dimensions of reel (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225



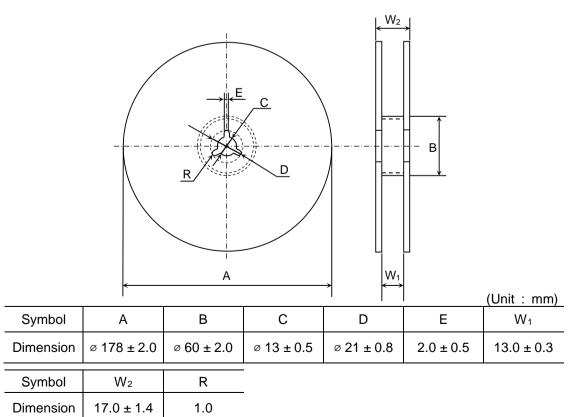
Unit : mr	<u>n)</u>

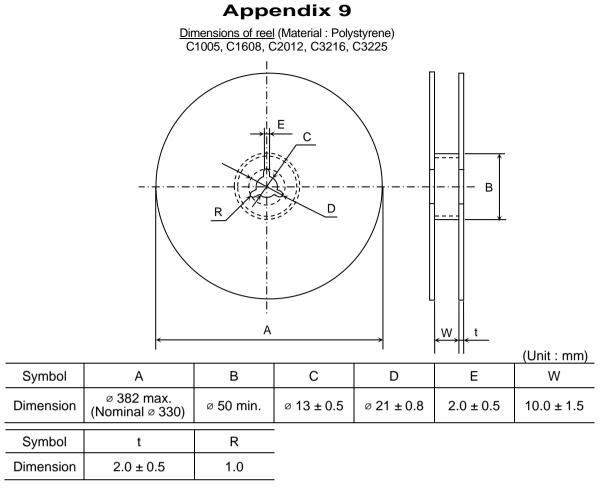
Symbol	А	В	С	D	Ш	W <sub>1</sub>
Dimension	ø 178 ± 2.0	ø 60 ± 2.0	ø 13 ± 0.5	ø 21 ± 0.8	$2.0 \pm 0.5$	9.0 ± 0.3
Symbol	W/a	R				

Symbol	W2	R	
Dimension	13.0 ± 1.4	1.0	

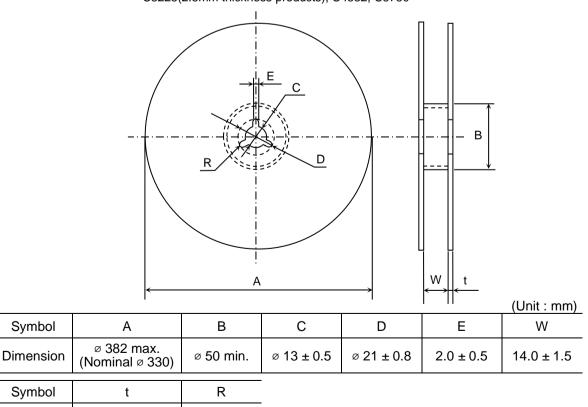
### **Appendix 8**

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750





<u>Dimensions of reel</u> (Material : Polystyrene) C3225(2.5mm thickness products), C4532, C5750



1.0

Dimension

 $2.0 \pm 0.5$